

Notice of References Cited	Application/Control No. 09/754,519		Applicant(s)/Patent Under Reexamination SHIBUYA ET AL.	
	Examiner Matthew T. Henning		Art Unit 2131	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,226,237 B1	05-2001	Chan et al.	710/14
*	B	US-6,038,672 A	03-2000	Klein, Dean A.	713/322
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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